## Applicant(s)/Patent Under Application/Control No. Reexamination 10/786,549 HIGUCHI ET AL. Notice of References Cited Examiner Art Unit Page 1 of 1 1756 John L Goodrow **U.S. PATENT DOCUMENTS** Document Number Date Classification Country Code-Number-Kind Code MM-YYYY Al. 02-2004 110.3 X US-В С US-US-D US-Ε US-F G US-US-Н US-US-J US-Κ US-L US-М **FOREIGN PATENT DOCUMENTS** Document Number Date Country Name Classification Country Code-Number-Kind Code MM-YYYY Ν 0 Ρ Q R s Т **NON-PATENT DOCUMENTS** Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) U ٧

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